RA-0005



- Silicon PIN/TIA
- 50MHz bandwidth
- Dynamic Range > 25dB

Performance Highlights

- Typical responsivity $12mV/\mu W$
- Differential output
- Suitable for fibre core diameters less than 100 $\mu m\,$

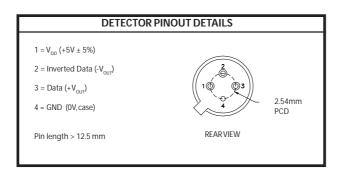
LIMITING VALUES	SYMBOL	VALUE	UNITS
Supply voltage	V _{DD} - GND	-0.3 to 6.0	V
Operating temperature	T _{amb}	-40 to +85	°C
Storage temperature	T_{stg}	-55 to +125	°C
Soldering temperature 2mm from case for 10s (either device)	T_{sld}	260	°C

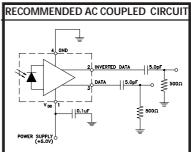
OPTICAL/ELECTRICAL CHARACTERISTICS	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITION
Responsivity	R	7.0	12.0	15.0	mV/μW	
Rise and fall times (10% - 90%)	t _r , t _f		7.5	8.5	ns	
Cutoff frequency	f _c	50			MHz	
Recommended operating wavelength	λο	750	800	900	nm	
Equivalent optical noise voltage	V _{no}			0.4	mV	
Equivalent optical noise input power	P _n		-45	-43	dBm	
Peak input power	P _r			-6	dBm	
Output impendance	Z _o		25	50	Ω	
DC output voltage	V _{out}	2.0	2.5	3.0	V	$P_r = 0 \mu W$
Power supply current	l _{ee}		15	20	mA	R _{load} = Infinite
Pulse width distortion (1)	PWD		0.25	2.0	ns	P _r = 1000 μW peak
Overshoot				3	%	
Power supply rejection ratio	PSRR	30			dB	

General test conditions unless otherwise stated: $0^{\circ}C < T_{amb} < +85^{\circ}C$, $+4.75V < V_{dd} < +5.25V$, $R_{load} = 500\Omega$, $C_{load} = 5pF$

- (1) Measured with a 10ns pulse width and 50% duty cycle at the 50% waveform amplitude point
- (2) Recommended resistive load > 400Ω
- (3) Recommended capacitative loading < 5.0 pF







NOTES:

1) The device is very susceptible to damage by electrostatic discharge.